

Notice of References CitedApplication/Control No.
10/026,019Applicant(s)/Patent Under
Reexamination
JOHNSON, RALPH H.Examiner
Tuan M NguyenArt Unit
2828

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | A | US-6,359,920 | 03-2002 | Jewell et al. | 372/46 |
| | B | US-6,252,894 | 06-2001 | Sasanuma et al. | 372/45 |
| | C | US-5,383,211 | 01-1995 | Van de Walle et al. | 372/43 |
| | D | US-5,251,225 | 10-1993 | Eglash et al. | 372/45 |
| | E | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
| | Q | | | | | |
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| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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